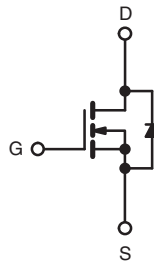


Power MOSFET

| PRODUCT SUMMARY | |
|---------------------------|-------------------------------|
| V_{DS} (V) | 600 |
| $R_{DS(on)}$ (Ω) | $V_{GS} = 10\text{ V}$ 0.21 |
| Q_g (Max.) (nC) | 180 |
| Q_{gs} (nC) | 61 |
| Q_{gd} (nC) | 85 |
| Configuration | Single |

TO-247AC



N-Channel MOSFET

FEATURES

- Superfast Body Diode Eliminates the Need for External Diodes in ZVS Applications
- Lower Gate Charge Results in Simpler Drive Requirements
- Enhanced dV/dt Capabilities Offer Improved Ruggedness
- Higher Gate Voltage Threshold Offers Improved Noise Immunity
- Compliant to RoHS Directive 2002/95/EC



RoHS*
COMPLIANT

APPLICATIONS

- Zero Voltage Switching (SMPS)
- Telecom and Server Power Supplies
- Uninterruptible Power Supplies
- Motor Control Applications

| ORDERING INFORMATION | |
|----------------------|----------------|
| Package | TO-247AC |
| Lead (Pb)-free | IRFP26N60LPbF |
| | SiHFP26N60L-E3 |
| SnPb | IRFP26N60L |
| | SiHFP26N60L |


| ABSOLUTE MAXIMUM RATINGS ($T_C = 25\text{ }^\circ\text{C}$, unless otherwise noted) | | | | |
|---|----------------------------------|-----------------------------------|---------------------|------------------|
| PARAMETER | SYMBOL | LIMIT | UNIT | |
| Drain-Source Voltage | V_{DS} | 600 | V | |
| Gate-Source Voltage | V_{GS} | ± 30 | | |
| Continuous Drain Current | V_{GS} at 10 V | $T_C = 25\text{ }^\circ\text{C}$ | A | |
| | | $T_C = 100\text{ }^\circ\text{C}$ | | |
| Pulsed Drain Current ^a | I_{DM} | 100 | | |
| Linear Derating Factor | | 3.8 | W/ $^\circ\text{C}$ | |
| Single Pulse Avalanche Energy ^b | E_{AS} | 570 | mJ | |
| Repetitive Avalanche Current ^a | I_{AR} | 26 | A | |
| Repetitive Avalanche Energy ^a | E_{AR} | 47 | mJ | |
| Maximum Power Dissipation | $T_C = 25\text{ }^\circ\text{C}$ | P_D | 470 | W |
| Peak Diode Recovery dV/dt^c | | dV/dt | 21 | V/ns |
| Operating Junction and Storage Temperature Range | | T_J, T_{stg} | - 55 to + 150 | $^\circ\text{C}$ |
| Soldering Recommendations (Peak Temperature) | for 10 s | | 300 ^d | |
| Mounting Torque | 6-32 or M3 screw | | 10 | lbf · in |
| | | | 1.1 | N · m |

Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- Starting $T_J = 25\text{ }^\circ\text{C}$, $L = 1.7\text{ mH}$, $R_g = 25\text{ }\Omega$, $I_{AS} = 26\text{ A}$, $dV/dt = 21\text{ V/ns}$ (see fig. 12).
- $I_{SD} \leq 26\text{ A}$, $dI/dt \leq 480\text{ A}/\mu\text{s}$, $V_{DD} \leq V_{DS}$, $T_J \leq 150\text{ }^\circ\text{C}$.
- 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

| THERMAL RESISTANCE RATINGS | | | | |
|-------------------------------------|------------|------|------|------|
| PARAMETER | SYMBOL | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient | R_{thJA} | - | 40 | °C/W |
| Case-to-Sink, Flat, Greased Surface | R_{thCS} | 0.24 | - | |
| Maximum Junction-to-Case (Drain) | R_{thJC} | - | 0.27 | |

| SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted) | | | | | | | |
|---|----------------------------|--|---|------|-----------|---------------|----|
| PARAMETER | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT | |
| Static | | | | | | | |
| Drain-Source Breakdown Voltage | V_{DS} | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$ | 600 | - | - | V | |
| V_{DS} Temperature Coefficient | $\Delta V_{DS}/T_J$ | Reference to $25\text{ }^\circ\text{C}, I_D = 1\text{ mA}$ | - | 0.33 | - | V/°C | |
| Gate-Source Threshold Voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$ | 3.0 | - | 5.0 | V | |
| Gate-Source Leakage | I_{GSS} | $V_{GS} = \pm 30\text{ V}$ | - | - | ± 100 | nA | |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = 600\text{ V}, V_{GS} = 0\text{ V}$ | - | - | 50 | μA | |
| | | $V_{DS} = 480\text{ V}, V_{GS} = 0\text{ V}, T_J = 125\text{ }^\circ\text{C}$ | - | - | 2.0 | mA | |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $V_{GS} = 10\text{ V}, I_D = 16\text{ A}^b$ | - | 0.21 | 0.25 | Ω | |
| Forward Transconductance | g_{fs} | $V_{DS} = 50\text{ V}, I_D = 16\text{ A}$ | 13 | - | - | S | |
| Dynamic | | | | | | | |
| Input Capacitance | C_{iss} | $V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1.0\text{ MHz}, \text{ see fig. 5}$ | - | 5020 | - | pF | |
| Output Capacitance | C_{oss} | | - | 450 | - | | |
| Reverse Transfer Capacitance | C_{rss} | | - | 34 | - | | |
| Effective Output Capacitance | $C_{oss\text{ eff.}}$ | | - | 230 | - | | |
| Effective Output Capacitance (Energy Related) | $C_{oss\text{ eff. (ER)}}$ | $V_{GS} = 0\text{ V}$ | $V_{DS} = 0\text{ V to } 480\text{ V}^c$ | - | 170 | - | |
| Total Gate Charge | Q_g | $V_{GS} = 10\text{ V}$ | $I_D = 26\text{ A}, V_{DS} = 480\text{ V}, \text{ see fig. 7 and 15}^b$ | - | - | 180 | nC |
| Gate-Source Charge | Q_{gs} | | | - | - | 61 | |
| Gate-Drain Charge | Q_{gd} | | | - | - | 85 | |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{DD} = 300\text{ V}, I_D = 26\text{ A}, R_g = 4.3\text{ }\Omega, V_{GS} = 10\text{ V}, \text{ see fig. 11a and 11b}^b$ | - | 31 | - | ns | |
| Rise Time | t_r | | - | 110 | - | | |
| Turn-Off Delay Time | $t_{d(off)}$ | | - | 47 | - | | |
| Fall Time | t_f | | - | 42 | - | | |
| Drain-Source Body Diode Characteristics | | | | | | | |
| Continuous Source-Drain Diode Current | I_S | MOSFET symbol showing the integral reverse p - n junction diode  | - | - | 26 | A | |
| Pulsed Diode Forward Current ^a | I_{SM} | | - | - | 100 | | |
| Body Diode Voltage | V_{SD} | $T_J = 25\text{ }^\circ\text{C}, I_S = 26\text{ A}, V_{GS} = 0\text{ V}^b$ | - | - | 1.5 | V | |
| Body Diode Reverse Recovery Time | t_{rr} | $T_J = 25\text{ }^\circ\text{C}, I_F = 26\text{ A}$ | - | 170 | 250 | ns | |
| | | $T_J = 125\text{ }^\circ\text{C}, dI/dt = 100\text{ A}/\mu\text{s}^b$ | - | 210 | 320 | | |
| Body Diode Reverse Recovery Charge | Q_{rr} | $T_J = 25\text{ }^\circ\text{C}, I_F = 26\text{ A}, V_{GS} = 0\text{ V}^b$ | - | 670 | 1000 | nC | |
| | | $T_J = 125\text{ }^\circ\text{C}, dI/dt = 100\text{ A}/\mu\text{s}^b$ | - | 1050 | 1570 | | |
| Reverse Recovery Current | I_{RRM} | $T_J = 25\text{ }^\circ\text{C}$ | - | 7.3 | 11 | A | |
| Forward Turn-On Time | t_{on} | Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D) | | | | | |

Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- Pulse width $\leq 300\text{ }\mu\text{s}$; duty cycle $\leq 2\%$.
- $C_{oss\text{ eff.}}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .
 $C_{oss\text{ eff. (ER)}}$ is a fixed capacitance that stores the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

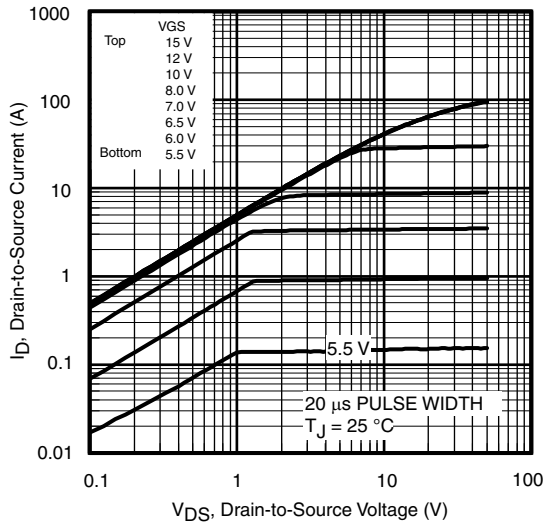


Fig. 1 - Typical Output Characteristics

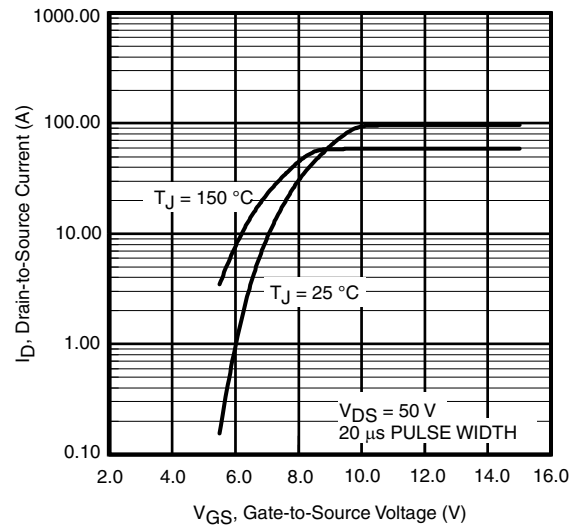


Fig. 3 - Typical Transfer Characteristics

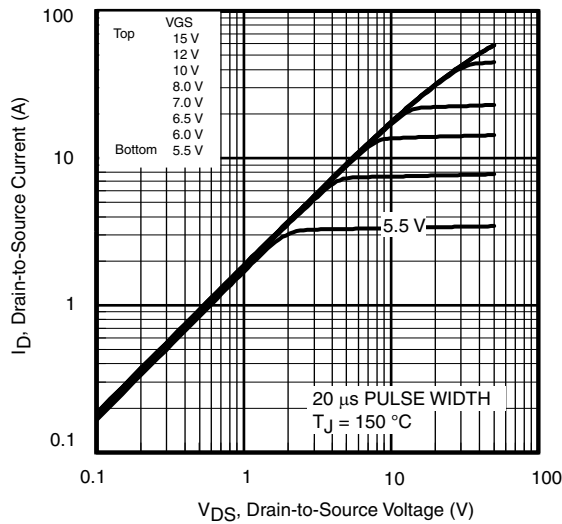


Fig. 2 - Typical Output Characteristics

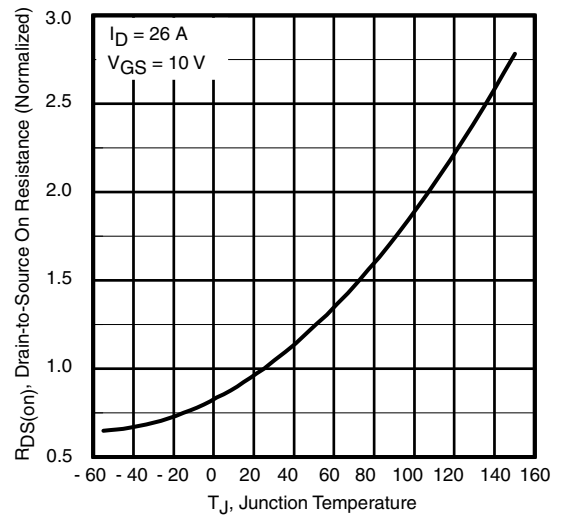


Fig. 4 - Normalized On-Resistance vs. Temperature

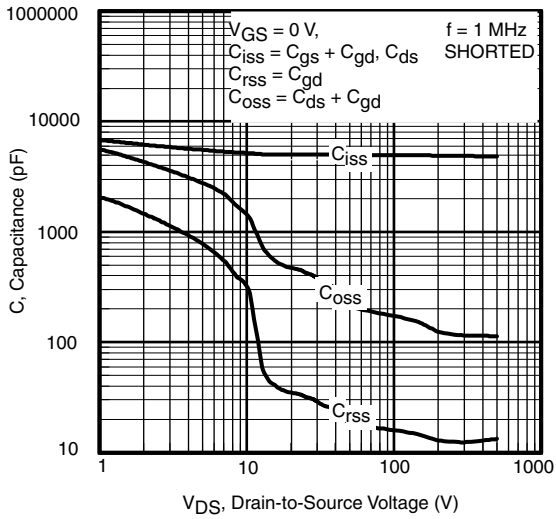


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

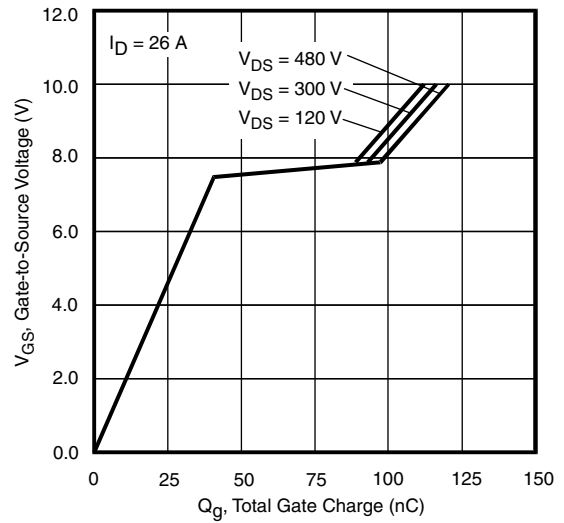


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

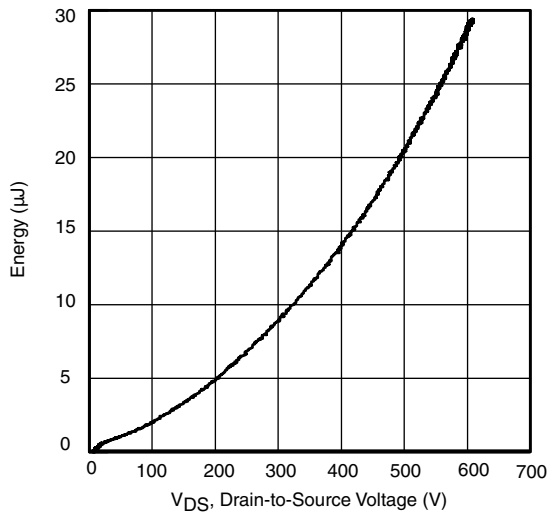


Fig. 6 - Typical Output Capacitance Stored Energy vs. V_{DS}

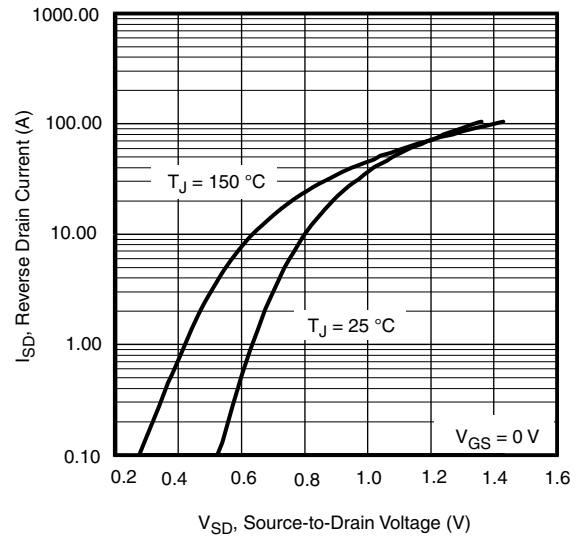


Fig. 8 - Typical Source-Drain Diode Forward Voltage

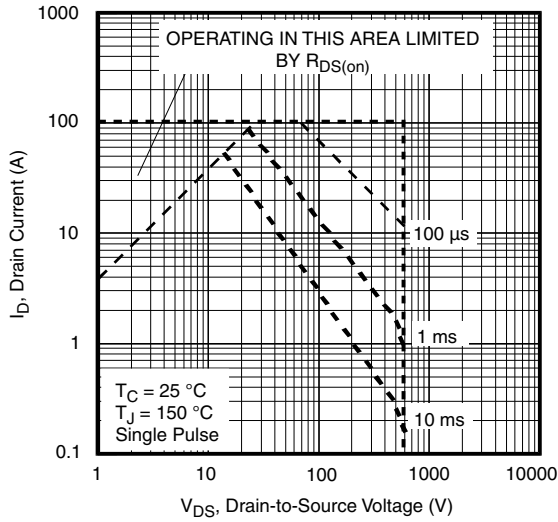


Fig. 9a - Maximum Safe Operating Area

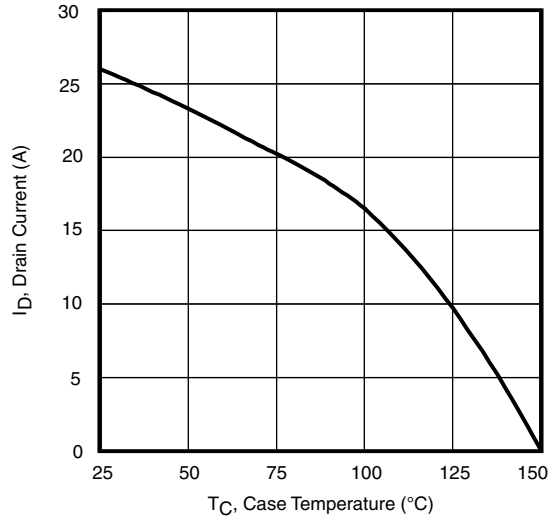


Fig. 10 - Maximum Drain Current vs. Case Temperature

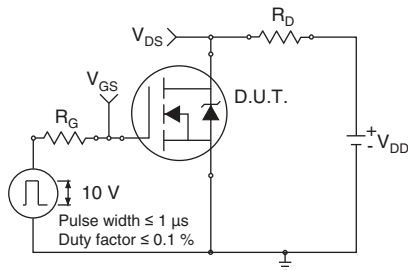


Fig. 11a - Switching Time Test Circuit

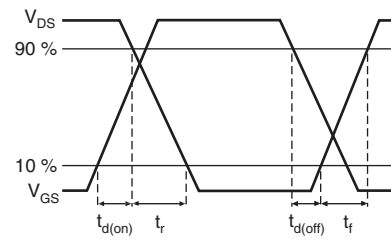


Fig. 11b - Switching Time Waveforms

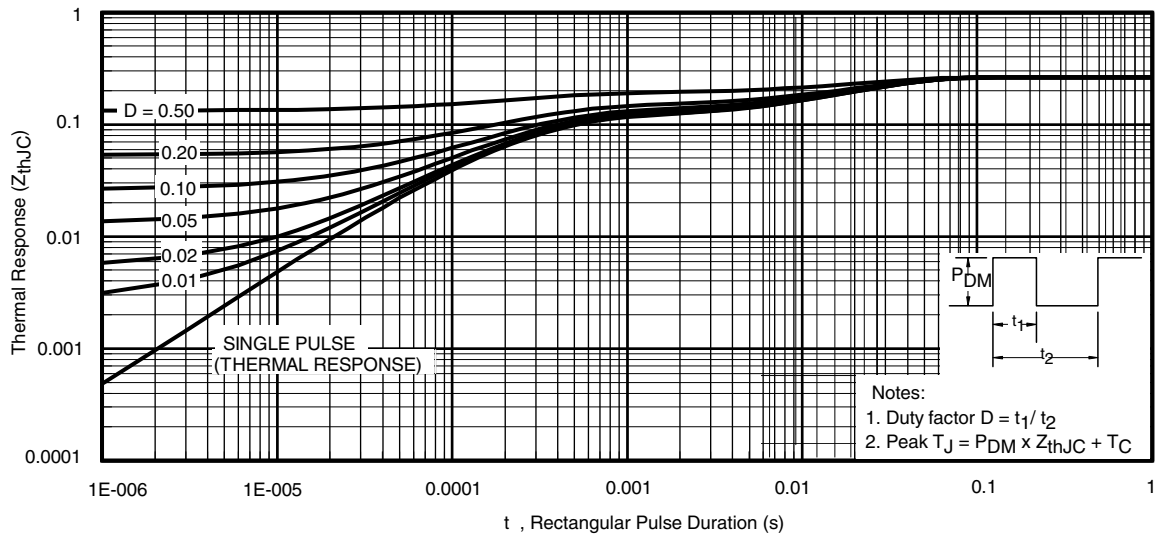


Fig. 12 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

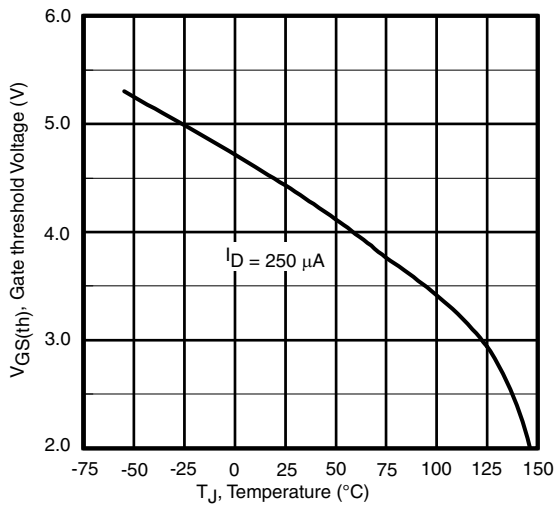


Fig. 13 - Threshold Voltage vs. Temperature

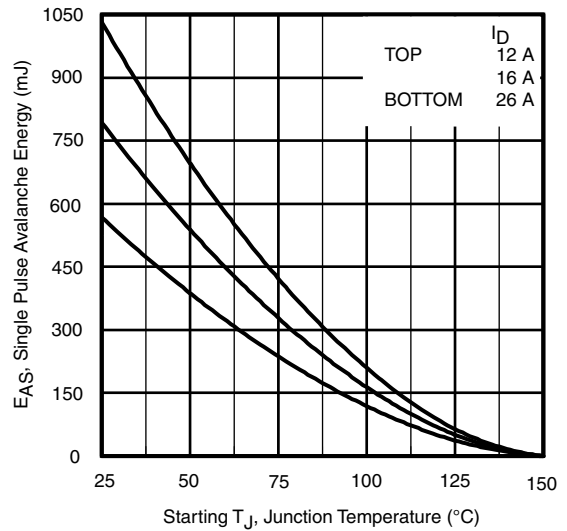


Fig. 14c - Maximum Avalanche Energy vs. Drain Current

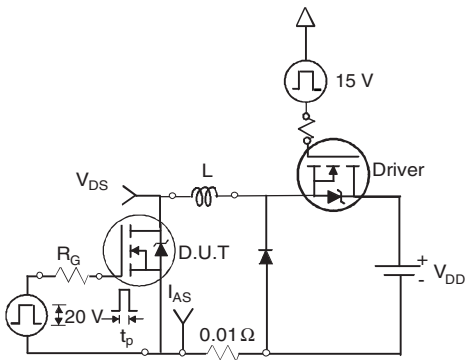


Fig. 14a - Unclamped Inductive Test Circuit

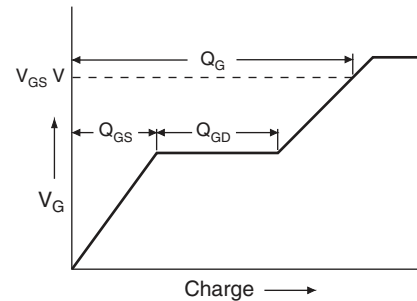


Fig. 15a - Basic Gate Charge Waveform

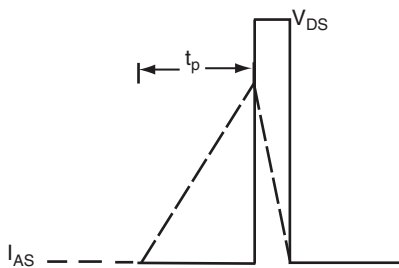


Fig. 14b - Unclamped Inductive Waveforms

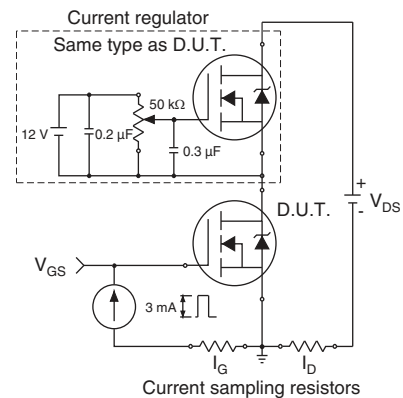
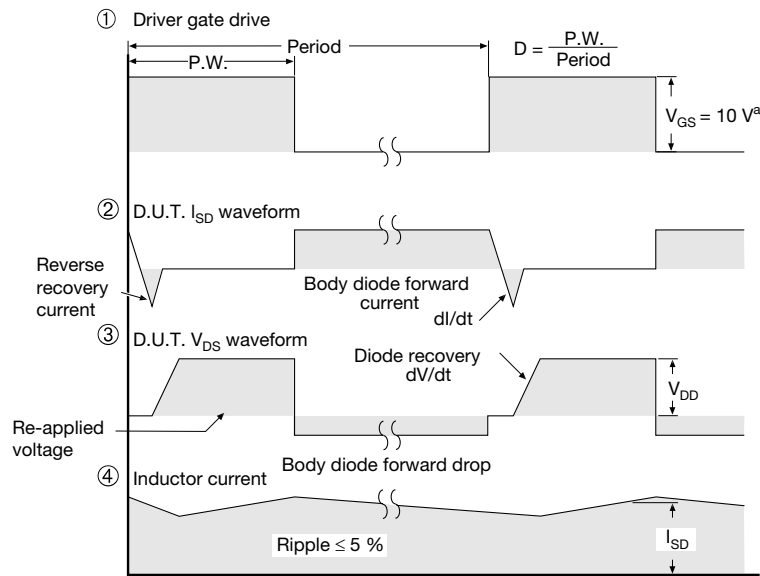
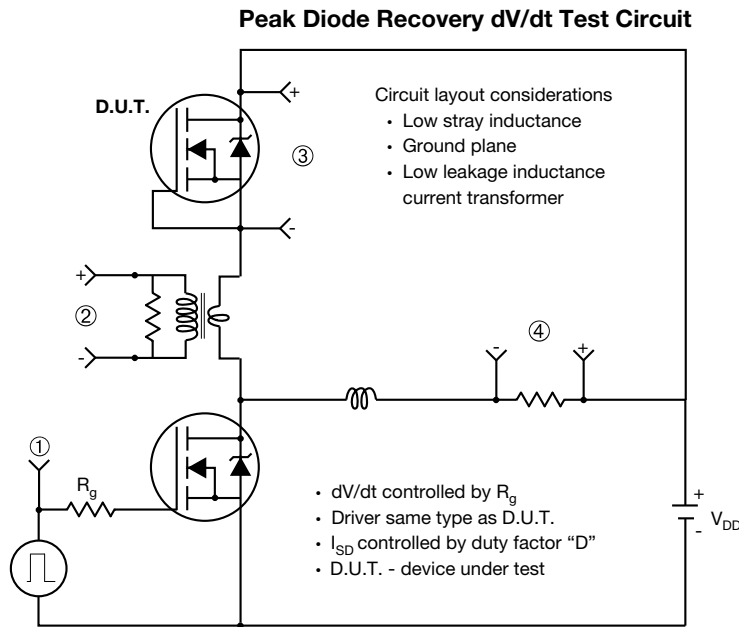


Fig. 15b - Gate Charge Test Circuit



Note
a. $V_{GS} = 5\text{ V}$ for logic level devices

Fig. 16 - For N-Channel

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